Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/659,384	BAE ET AL.
Examiner	Art Unit
Hoai v. Pham	2814

	SEARCHED			
Class	Subclass	Date	Examiner	
257	336	6/22/2005	НР	
257	337	6/22/2005	HP	
257	338	6/22/2005	НР	
257	369	6/22/2005	HP	
257	388	6/22/2005	HP	
257	407	6/22/2005	НР	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING	RCH NOTE SEARCH S	TRATEGY)
		DATE	EXMR
East search		6/22/2005	НР
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